

**Search Notes**

Application/Control No.

10/650,149

Examiner

William J. Deane

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	211.02	13 Jun 07	WJ
	37		
	↓		
	40		
	211.01		
	212.01		
	219		
6	↓		
	221.02		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR